

23rd International Congress on X-ray Optics and Microanalysis (ICXOM23)

Wednesday, 16 September 2015

Ptychography and CDI II - Berkner Hall, Auditorium (15:50 - 17:10)

time	[id] title	presenter
15:50	[66] Simultaneous and sequential X-ray ptychography and fluorescence microscopy at the Australian Synchrotron	JONES, Michael
16:10	[67] Diffraction imaging with coherent X-rays from SACLA and SPring-8	NAM, Daewoong
16:30	[68] Three-dimensional mapping of strain field in SiGe thin film	HU, Wen
16:50	[69] Investigation of diffuser influence in near-field ptychography	CHALKIDIS, Stefanos